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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/534,622	01/24/2006	Seung-Woo Lee	AB-1707 US	5616
32605 MACPHERSO	7590 02/12/200 ON KWOK CHEN & H	EXAM	EXAMINER	
2033 GATEWAY PLACE SUITE 400 SAN JOSE, CA 95110			LEE JR, KENNETH B	
			ART UNIT	PAPER NUMBER
			2629	
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			02/12/2009	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

All participants (applicant, applicant's representative, PTC	D personnel):				
(1) <u>KENNETH B. LEE JR</u> .	(3)				
(2) <u>Alma Levy</u> .	(4)				
Date of Interview: 10 February 2009.					
Type: a)⊠ Telephonic b)□ Video Conference c)□ Personal [copy given to: 1)□ applicant	2) applicant's representative]				
Exhibit shown or demonstration conducted: d) Yes If Yes, brief description:	e)⊠ No.				
Claim(s) discussed: 1.					
Identification of prior art discussed: <u>Lee, US Patent #7,030.846</u> .					
Agreement with respect to the claims f) was reached.	g) was not reached. h) N/A.				
Substance of Interview including description of the gener reached, or any other comments: <u>Examiner and Attorney input image data into output image data that have gamme bit number greater than the input image data.</u> Applicant amore detail.	discussed claim 1 limitation "gamma converter converting a characteristic adapted to a gamma 2.2 curve and have a				
(A fuller description, if necessary, and a copy of the amer allowable, if available, must be attached. Also, where no allowable is available, a summary thereof must be attach					
GIVEN A NON-EXTENDABLE PERIOD OF THE LONGEI	ne last Office action has already been filed, APPLICANT IS R OF ONE MONTH OR THIRTY DAYS FROM THIS ITERVIEW SUMMARY FORM, WHICHEVER IS LATER, TO				
KBL	/Bipin Shalwata/ Supervisory Patent Examiner, Art Unit 2629				
I.S. Datast and Tradamark Office					